Se	arch Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/568,840	ECKL ET AL.	
Examiner	Art Unit	
David B. Jones	3725	

	SEAR	RCHED	
Class	Subclass	Date	Examiner
59	78.	3/4/07	DT
248	49		
	51	3/4/07	DJ

INT	ERFERENC	E SEARCH	IED
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
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